

6 Easy-to-use (ETU) Tools for Uncertainty Quantification (UQ) with Example Applications to Engineering Research & Practice (*)

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5/4/2018

Outline of Talk (1 + 2 + 3 + 4 + 8 = 60 slides)

- 1. Why is UQ important in Engineering ?
- 2. Example of an *Easy-to-use* UQ Tool for Engineers.
- 3. Six Easy-to-use (ETU) Tools of Engineering UQ.
- 4. Tool-2, 3, 4, 5. UQ for Brain Metrology Research.
- 5. Tool-3, & 5. UQ for Flaw Detection and Sizing.
- 6. Tool-1 & 2. UQ for Design of an Aircraft Window.
- 7. Tool-6. UQ for Maintenance Decision Making.
- 8. Concluding Remarks.



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Question-1: When artificial intelligence (AI) makes a lethel mistake, how do we assess blame?

Washington Post, Sunday, Mar. 25, 2018, page B.5

1.



The location in Tempe, Ariz., where a self-driving Uber vehicle struck a pedestrian last weekend. Artificial intelligence systems can't always explain what they were "thinking" when such accidents occur.





CHRIS CARLSON/ASSOCIATED PRESS





1. Why is UQ important in Engineering?

Question-2: When an engineering judgment makes a lethal mistake, how do we assess blame?

Washington Post, March 21, 2018 page A7



Thursday Mar. 15 **2018**

6

deaths

5

PEDRO PORTAL/MIAMI HERALD/ASSOCIATED PRESS

The pedestrian bridge at Florida International University under construction. The 950-ton bridge collapsed Thursday, resulting in six deaths.



1. Why is UQ important in Engineering?

Question-3: When a maintenance judgment makes a lethal mistake, how do we assess blame?

Southwest Airlines Flight Makes Emergency Landing At Philadelphia International Airport



Tuesday Apr. 17 2018



JIST



1. Why is UQ important in Engineering ?

Ans. Because an engineer's decision in design, manufacture, operation, and maintenance needs <u>estimates of stress</u> <u>with credible uncertainty bounds</u> for safe operation and failure prevention.



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1a.

Why is UQ important in Engineering Research?

Atomic Force Microscope







FIG. 6. Friction force vs load for Si(100) obtained with(a) FFM (150 nm tip radius), (b) SFM (100 nm tip radius), (c) SFM (16 JLm tip radius), and (d) POD (1.2 nm pin radius).

Ref.: Niederberger, S., Gracias, D. H., Komvopoulos, K., Somorjai, G. A., *J. Appl. Phys.*, Vol. 87, No. 6, pp. 3143-3150 (2000).





5/4/2018







Jeffrey T. Fong, NIST, Gaithersburg, MD



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Ans. Large scale simulations is often used to conduct fundamental research at the nano- and micro-scales. As the scale changes, forces and factors that are dominant at one scale may change at a different scale. Design of experiments tool allows one to rank the importance of factors at one scale, estimate uncertainty, re-formulate for a higher scale by discarding less dominant factors and add new factors to guide the design of a new experiment at a higher scale.



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3. Six Easy-to-use Tools of Eng. UQ

- 3.1 Goodness-of-Fit (GoF) Test for 64 distributions.
- 3.2 **Predictive Limits & Lower Tolerance Limit (***LTL***)**.
- 3.3 Linear Least SQuares (*LLSQ* Regression).
- 3.4 Inter-laboratory comparison (*R&R*) and Variance Analysis (*ANOVA*).

Relatively new to Engineers

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- 3.5 Design of Experiments (**DEX**).
- 3.6 Non-Linear Least SQuares with Logistic



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3. Six Easy-to-use Tools of Eng. UQ

- 3.1 Goodness-of-Fit (Go^{-1} Test for 64 distributions.
- 3.2 Predictive Limits & Lower Relevance Limit (LTL).
- 3.3 Linear Least SQuares (*LLSQ* Regression).
- 3.4 Inter-laboratory comparison and Variance Analysis (ANOVA).
- What does one mean by **Easy-to-use** ?
- 3.5 Design of Experiments (**DEX**).
- 3.6 Non-Linear Least SQuares with Logistic Function (*NLLSQ* Lgs).



2. Referenced Documents

2.1 ASTM Standards:"

Calibration Error

ASTM Test Methods

hazards statements are given in Section 8 on Hazards.

D6091 Practice for 99 %/95 % Interlaboratory Detection

E177 Practice for Use of the Terms Precision and Bias in

E200 Practice for Preparation, Standardization, and Storage

E288 Specification for Laboratory Glass Volumetric Flasks

E456 Terminology Relating to Quality and Statistics

of Standard and Reagent Solutions for Chemical Analysis

Estimate (IDE) for Analytical Methods with Negligible



Designation: E2677 - 14

Standard Test Method for Determining Limits of Detection in Explosive Trace Detectors¹

1.3 This particular test method was chosen on the basis of reliability, practicability, and comprehensiveness across tested ETDs, analytes, and deployment conditions. The calculations involved in this test method are published elsewhere (4), and may be performed consistently with an interactive web-based tool available on the National Institute of Standards and Technology (NIST) site: http://pubapps.nist.gov/loda.

1.4 Intended Users-ETD developers, ETD vendors, ETD buyers, ETD testers, ETD users (hist responders, security screeners, and the military), and ag noise responsible for public safety and enabling effective deterents to terrorism.

1.5 While this test method may be append to any detection

technology that p have been designed ETD systems and compounds, Comp swabs and dried be

¹ This test method i Homeland Security App E54,01 on CBRNE Sens Current edition appro E2677-14. ² The boldface number this standard. 1.3 This particular test method was chosen on the basis of reliability, practicability, and comprehensiveness across tested ETDs, analytes, and deployment conditions. The calculations involved in this test method are published elsewhere (4), and may be performed consistently with an interactive web-based tool available on the National Institute of Standards and Technology (NIST) site: http://pubapps.nist.gov/loda.

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ASTM E2677 Limit of Detection Web Portal Data Entry Page

You can view a <u>description of the limits of detection analysis</u> performed here and the <u>data</u> <u>requirements</u> for the analysis.

Enter column of analyte level (mass)

Enter column of response data (signal)



ASTM E2677 Limit of Detection Web Portal Data Entry Page

Optional Input Options

| Enter the | confidence | <u>e limit</u> foi | r the LOD | and for | the |
|-----------|------------|--------------------|-----------|---------|-----|
| tolerance | bound (ga | mma): | | | |

Enter the <u>coverage</u> for the tolerance bound (p):

Enter the probability of a false negative (signal, no alarm) (beta):

Enter the probability of a false positive (no signal, but alarm sounds) (alpha):

| 0.10 | | |
|------|------|--|
| 0.10 | | |
| 0.10 | | |

| 0.10 |
|------|
|------|



| Output Options | |
|--|---|
| Title: | |
| Print estimate of critical value: Generate Data Summary Table Generate LOD Summary Table | Yes ● No Yes ● No Yes ● No |
| Generate graphs: | SVG (IE9, other browsers) JPEG (IE8 and below) None |
| Generate Grubbs Outlier Output: | ○ Yes ● No |
| Enter the number of digits to the right of the decimal point for the tables: | 4 |





Input Data File-1

| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|---------|---|-----|-----|----|-----|-----|---|---|---|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0. | 1 | 0.1 | 0 | .1 | 0.1 | 0.3 | 1 | | |
| 0.1 0.1 | | 0.1 | 0 | .1 | 0.1 | 0.1 | | | |
| 0. | 1 | 0.1 | 0.1 | | 0.1 | 0.3 | 1 | | |
| 0. | 3 | 0.3 | 0.3 | | 0.3 | 0.3 | 3 | | |
| 0. | 3 | 0.3 | 0.3 | | 0.3 | 0.3 | | | |
| 0. | 3 | 0.3 | 0 | .3 | 0.3 | 0.3 | | | |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| 1 | 1 | 1 | 1 | 1 | 3 | 3 | 3 | 3 | 3 |
| 3 | 3 | 3 | 3 | 3 | 3 | 3 | 3 | 3 | 3 |

Input Data File-2

| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 212 | 251 |
|-----|-----|-----|-----|-----|-----|------|-----|-----|-----|
| 239 | 0 | 0 | 0 | 0 | 0 | 188 | 0 | 180 | 0 |
| 170 | 219 | 213 | 0 | 0 | 0 | 0 | 250 | 191 | 200 |
| 223 | 214 | 193 | 0 | 0 | 0 | 0 | 202 | 173 | 0 |
| 0 | 0 | 0 | 294 | 174 | 242 | 0 | 0 | 272 | 203 |
| 189 | 211 | 212 | 239 | 282 | 198 | 0 | 191 | 223 | 218 |
| 236 | 177 | 274 | 244 | 342 | 222 | 237 | 261 | 279 | 284 |
| 255 | 248 | 338 | 426 | 279 | 280 | 264 | 313 | 351 | 321 |
| 400 | 283 | 349 | 357 | 344 | 749 | 614 | 739 | 861 | 711 |
| 751 | 654 | 695 | 689 | 611 | 726 | 1651 | 756 | 693 | 781 |





Title:

| 0 | ut | tp | ut | 0 | pt | io | ns |
|---|----|----|----|---|----|----|----|
| | | | | | • | | |

Demo for May 4, 2018 Talk at UTAR Print estimate of critical value: Yes No Generate Data Summary Table Yes No Generate LOD Summary Table Yes No Generate graphs: SVG (IE9, other browsers) JPEG (IE8 and below) \bigcirc None Generate Grubbs Outlier Output: Yes O No Enter the number of digits to the right of the decimal 4 point for the tables:

Calculate LOD

Reset



An Invited Presentation at UTA Research Institute, May 4, 2018, 12 noon (Prof. Ken reifsnider, host)

ASTM E2677 Limits of Detection Analysis

Demo for May 4, 2018 Talk at UTARI 2018/05/01 - 15:48:56

LIMITS OF DETECTION ANALYSIS

| Final Estimate: | Summary Table | | | | | | | | | |
|--|---------------|-------------|-----------------|-----------------|-----------------|--|--|--|--|--|
| Critical Value (CV90) = 222.6 | | | | | | | | | | |
| Detection Limit (LOD90) = 0.7836 | Mass | Number of | Number of | Mean of | SD of | | | | | |
| 0% Upper Confidence Limit on LOD = 1.160 | Values | Zero Values | Non-Zero Values | Non-Zero Values | Non-Zero Values | | | | | |
| | 0.0000 | 24 | 16 | 207.3750 | 25.1101 | | | | | |
| | 0.1000 | 5 | 10 | 231.8000 | 40.8080 | | | | | |
| | 0.3000 | 1 | 14 | 241.8571 | 43.5729 | | | | | |
| | 1.0000 | 0 | 15 | 320.5333 | 52.7445 | | | | | |
| | 3.0000 | 0 | 15 | 778.7333 | 249.5686 | | | | | |



An Invited Presentation at UTA Research Institute, May 4, 2018, 12 noon (Prof. Ken reifsnider, host)





| | | Alpha | CDF | Critical Value | Conclusion | | |
|---------------|----------|-----------------------|--------------------|----------------|------------|--|--|
| No of clidas | Subtotal | 10% | 90% | 2.443 | Accept H0 | | |
| NO. OJ SILVES | Sublolui | 5% | 95% | 2.586 | Accept H0 | | |
| | | 2.5% | 97.5% | 2.710 | Accept H0 | | |
| 10 | 20 | 1% | 99% | 2.852 | Accept H0 | | |
| | | Jeffrey T. Fong, NIST | , Gaithersburg, MD | NIC. | | | |

5/4/2018

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3. Six Easy-to-use Tools of Eng. UQ

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Relatively new to Engineers

dards and Techn

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- 3.5 Design of Experiments (**DEX**).
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[00]-1 Goodness-of-Fit (GoF) Test for 64 distributions.

Compare N-PC, N-ML, 2pW-ML, 3pW-ML, and 3pW-PC Plot-4: 2pW-ML (2-Parameter Weibull Distribution Fit with ML Method) Actual Values of Sorted Strength Data (MPa) 400 2p Weibull Probability Plot 350 300 Poor Fit 250 200 Sample Size = 31. 150



100

100

150

200

250

Fitted Values of 2p-Weibull (0, 232.18, 4.64) Max-Like Method: Strength (MPa)

PPCC = 0.9739

300

350

400





Tool-1 Goodness-of-Fit (*GoF*) Test for *64* distributions.

An Alphabetised List of 64 Models "Ranked" by 7 Goodness-of-Fit Tests

| Ľ | No | Name of Candidate Distribution | MLE / AD | MLE / KS | MLE / BIC | PPCC / AD | PPCC / KS | PPCC / BIC | PPCC / PPCC |
|---|----|--------------------------------|----------|----------|-----------|-----------|-----------|------------|-------------|
| Γ | 1 | 1-PAR MAXWELL | 5 | 5 | 8 | No. | No. | No. | No. |
| Ī | 2 | 2-COMP NORMAL MIXTURE | 4 | 4 | 7 | No. | No. | No. | No. |
| | 3 | 2-PARA BETA | 7 | 7 | 6 | No. | No. | No. | No. |
| Τ | 4 | 2-PARA BURR TYPE 10 | 10 | 10 | 9 | No. | No. | No. | No. |
| Γ | 5 | 2-PARA FRECHET (MAXIMUM) | 9 | 8 | 9 | No. | No. | No. | No. |
| Γ | 6 | 2-PARA FRECHET (MINIMUN) | 4 | 4 | 7 | No. | No. | No. | No. |
| | 7 | 2-PARA GAMMA | 9 | 9 | 10 | No. | No. | No. | No. |
| | 8 | 2-PARA GEOM EXTREME EXPO | -5 | 4 8 | | No. | No. | No. | No. |
| ſ | 9 | 2-PARA INVERTED GAMA | 9 | 9 | 10 | No. | No. | No. | No. |
| | 10 | 2-PARA INVERTED WEIBULL | 9 | 8 | 9 | No. | No. | No. | No. |
| | 11 | 2-PARA LOGNORMAL | 10 | 10 | 10 | No. | No. | No. | No. |
| | 12 | 2-PARA MAXWELL | No. | No. | No. | 9 | 9 | 9 | 9 |
| | 13 | 2-PARA WEIBULL (MAXIMUM) | 5 | 4 | 4 | No. | No. | No. | No. |
| | 14 | 2-PARA WEIBULL (MINIMUM) | 8 | 7 | 5 | No. | No. | No. | No. |
| | 15 | 3-PARA BURR TYPE 10 | No. | No. | No. | 10 | 9 | 8 | 9 |
| | 16 | 3-PARA FRECHET (MAX) | No. | No. | No. | 7 | 6 | 6 | 4 |
| | 17 | 3-PARA FRECHET (MIN) | No. | No. | No. | 1 | 1 | 10 | 2 |
| | 18 | 3-PARA GAMMA | No. | No. | No. | 9 | 8 | 7 | 8 |
| | 19 | 3-PARA GEOM EXTREME EXPO | No. | No. | No. | 9 | 8 | 7 | 6 |
| | 20 | 3-PARA INVERTED GAMMA | No. | No. | No. | 7 | 7 | 6 | 7 |



An Alphabetised List of 64 Models "Ranked" by 7 Goodness-of-Fit Tests

| No | Name of Candidate Distribution | MLE / AD | MLE / KS | MLE / BIC | PPCC / AD | PPCC / KS | PPCC / BIC | PPCC / PPCC |
|----|--------------------------------|----------|----------|-----------|-----------|-----------|------------|-------------|
| 21 | 3-PARA INVERTED WEIBULL | No. | No. | No. | 7 | 5 | 6 | 4 |
| 22 | 3-PARA LOGNORMAL | No. | No. | No. | 8 | 8 | 6 | 7 |
| 23 | 3-PARA WEIBULL (MAXIMUM) | No. | No. | No. | 9 | 7 | No. | 8 |
| 24 | 3-PARA WEIBULL (MINIMUM) | 10 | 10 | 5 | 10 | 9 | 2 | 10 |
| 25 | 4-PARA BETA | 9 | 10 | 5 | No. | No. | No. | No. |
| 26 | ANGLIT | No. | No. | No. | 5 | 6 | 9 | 5 |
| 27 | ARCSINE | No. | No. | No. | 3 | 2 | 10 | 3 |
| 28 | ASYMMETRIC DOUBLE EXPO | No. | No. | No. | 2 | 1 | 4 | No. |
| 29 | BIRNBAUM SAUNDERS | 7 | 9 | 8 | 9 | 8 | 7 | 8 |
| 30 | BRADFORD | No. | No. | No. | 3 | 4 | 9 | 9 |
| 31 | CAUCHY | 6 | 6 | 8 | 2 | 2 | 4 | 1 |
| 32 | COSINE | No. | No. | No. | 6 | 5 | 9 | 5 |
| 33 | DOUBLE EXPONENTIAL | 6 | 6 | 7 | 4 | 3 | 4 | 2 |
| 34 | DOUBLE GAMMA | No. | No. | No. | 10 | 10 | 8 | 7 |
| 35 | DOUBLE WEIBULL | No. | No. | No. | 8 | 10 | 8 | 7 |
| 36 | ERROR | No. | No. | No. | 6 | 7 | 6 | 6 |
| 37 | EXPONENTIAL (2-PARA) | 4 | 5 | 5 | 2 | 2 | 2 | 2 |
| 38 | FOLDED NORMAL | 8 | 7 | 10 | No. | No. | No. | No. |
| 39 | G AND H | No. | No. | No. | 8 | 7 | 4 | 7 |
| 40 | GENERALIZED EXT VAL (MAX) | No. | No. | No. | 8 | 7 | 7 | 8 |
| 41 | GENERALIZED EXT VAL (MIN) | No. | No. | No. | 10 | 9 | 8 | 9 |
| 42 | GENERALIZED PARETO (MAX0 | No. | No. | No. | 3 | 10 | 10 | 10 |



An Alphabetised List of 64 Models "Ranked" by 7 Goodness-of-Fit Tests

| Ne | 0 | Name of Candidate I | Distribution | MLE | E/AD | MLE | E/KS | MLE | / BIC | PPCC | /AD | PPCO | C/KS | PPCC | BIC | PPCC / PPCC | |
|-----|----|---------------------|--------------|-----|------|-----|------|-----|-------|------|-----|------|------|------|-----|-------------|-----|
| 4 | 3 | GENERALIZED PAR | ETO (MIN) | | No. | | No. | | No. | 1 | | 9 | | 10 | | 6 | |
| 4 | 4 | GUMBEL (MAXIMU | M) | 10 | | 8 | | 6 | | 7 | | 6 | | 3 | | 5 | |
| 4 | 5 | GUMBEL (MINIMUN | <u>(1)</u> | 6 | | 6 | | 4 | | 4 | | 3 | | 3 | | 2 | |
| 4 | .6 | HALF-NORMAL | | | No. | | No. | | No. | 3 | | 3 | | 8 | | 5 | |
| 4 | .7 | HYPERBOLIC SECA | NT | | No. | | No. | | No. | 4 | | 4 | | 5 | | 3 | |
| 4 | 8 | LOG DOUBLE EXPO | NENTIAL | | No. | | No. | | No. | 4 | | 3 | | 4 | | 3 | |
| 4 | .9 | LOG GAMMA | | | No. | | No. | | No. | 5 | | 4 | | 5 | | 3 | |
| 5 | 0 | LOG LOGISTIC | _ | | No. | | No. | | No. | 6 | | 5 | | 5 | | 4 | |
| 5 | 1 | LOGISTIC | | 8 | | 8 | | 4 | | 5 | | 4 | | 2 | | 3 | |
| 5 | 2 | LOGISTIC EXPONEN | JTIAL | 8 | | 9 | | 9 | | 6 | | 5 | | 5 | | 5 | |
| - 5 | 3 | NORMAL | | 8 | | 7 | | 5 | | 6 | | 5 | | 3 | | 4 | |
| 5 | 4 | PARETO | | 5 | | 5 | | 8 | | | No. | | No. | | No. | | No. |
| 5 | 5 | POWER | | 6 | | 5 | | 6 | | 4 | | 4 | | 3 | | 6 | |
| 5 | 6 | RAYLEIGH | | 6 | | 6 | | 9 | | 10 | | 10 | | 9 | | 9 | |
| 5 | 7 | REFL GENE TOPP A | ND LEONE | 7 | | 6 | | 7 | | | No. | | No. | | No. | | No. |
| 5 | 8 | REFLECTED POWER | 2 | 7 | | 7 | | 7 | | 5 | | 6 | | 3 | | 10 | |
| 5 | 9 | SLASH | | 7 | | 9 | | 4 | | 2 | | 2 | | 2 | | 2 | |
| 6 | 0 | TOPP AND LEONE | | 5 | | 8 | | 6 | | 7 | | 10 | | | No. | 10 | |
| 6 | 1 | TRIANGULAR | | 10 | | 10 | | 10 | | 3 | | 3 | | 10 | | 10 | |
| 6 | 2 | TUKEY-LAMBDA | | | No. | | No. | | No. | 5 | | 6 | | 7 | | 6 | |
| 6 | 3 | UNIFORM | | 4 | | 5 | | 6 | | 2 | | 2 | | 2 | | 4 | |
| 6 | 4 | WALD | | | No. | | No. | | No. | 8 | | 8 | | 5 | | 8 | |





Tool-2 Predictive Limits 8 Lower Tolerance Limit (LTL).





Tool-2 Predictive Limits & Lower Tolerance Limit (*LTL*).

3 intervals for Error Estimation

| | Coni < Predi < TOII. | n = sample size. |
|--|----------------------------------|----------------------------|
| coni = (<i>m</i> – <i>d1 * s , m</i> + <i>d1 * s</i>), with | | $1 - \alpha = confidence.$ |
| | $d1 = t(\alpha/2, n-1)/sqrt(n).$ | |
| | | t = t-distribution. |
| Predi: | d2 = t(α/2,n-1)*sqrt(1+1/n). | df = n-1. |
| Toli: | d3 = r * u, | p = coverage. |
| | | |

r = r(p, n), and $u = u(1 - \alpha, df)$



Q.-3.2.1 What is a t-distribution?





For v = n - 1 = df, the p.d.f. (probability density function) of a *t*-distribution (t; v) is given by f(x; v) = $\{\Gamma[(\nu+1)/2]\}$ $(\pi\nu)^{1/2}\Gamma(\nu/2)[1+(x^2/\nu)]^{(\nu+1)/2}$ where its mean = 0, (v>1), and its variance = v/(v-2), (v>2).



Q.-3.2.2 How does one calculate a **Confidence interval (Coni)**?

An example of a 10-data set of the ultimate tensile strength (MPa) of a material X is given below by an ordered set of 10 numbers:

73, 76, 80, 90, 100, 100, 110, 120, 124, 127, where n = 10, m = 100, and s.d. = 20. From the t-table, t (0.025, 9) = 2.262. From the formula for d1, d1 = 2.262 * 20 * sqrt (1/10) = 14.31. Therefore, the confidence interval at 95 % C.L. is, (86, 114).



Q.-3.2.3 How does one calculate a predictive interval (Predi)?

An example of a 10-data set of the ultimate tensile strength (MPa) of a material X is given below by an ordered set of 10 numbers: 73, 76, 80, 90, 100, 100, 110, 120, 124, 127, where n = 10, m = 100, and s.d. = 20. From the t-table, t (0.025, 9) = 2.262. From the formula for d2, d2 = 2.262 * 20 * sqrt (1+1/10) = 47.45. Therefore, predictive interval at 95 % C.L. is, (53, [data set] 147).

Note: Predictive interval is always wider than Confidence Interval.



3.2 **Predictive Limits & Lower Tolerance Limit (***LTL***)**.



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Tool-3 Linear Least Squares (*LLSQ* - Regression).









Tool-3 Linear Least SQuares (*LLSQ* - Regression).



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Tool-4 **Repeatability and Reproducibility (***R&R***) Analysis** and Variance Analysis (ANOVA).





E691 INTERLAB (R&R)

Ref: "Standard Practice for Conducting an Interlaboratory Study to Determine the Precision of a test Method," ASTM International, West Conshohoceken, PA 19428-2959.

The purpose of the E691 INTERLAB command is to estimate the *precision* of a test method. Two important concepts in termining the precision are:

- 1. Repeatability repeatability concerns the variability between independent test results obtained within a single laboratory in the shortest practical period of time by a single operator with a specific set of test apparatus using test specimens taken at random from a single quantity of homogeneous material.
- 2. Reproducibility reproducibility is the variability between single test results obtained in different laboratories, each of which has applied the test method to test specimens taken at random from a single quantity of homogeneous material.





Analysis of Variance (ANOVA)

Description: Analysis of Variance (ANOVA) is a data analysis technique for examining the *significance* of the factors (= independent variables) in a multi-factor model.

The number of factors must be between 1 and 5 inclusive. Each factor then has a certain number of values it can have (referred to as the levels of a factor). The number of levels does not have to be the same for each factor.

Each factor and level combination is a cell (the number of cells is the product of the number of levels in each factor).

Balanced designs are those in which each cell has an equal number of observations and unbalanced designs are those in which the number of observations can vary between cells.





Tool-5 Design of Experiments (DEX).

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Tool-5 Design of Experiments (*DEX*).



Figure 1. (left) A full-factorial 8-run orthogonal design for 3 factors. (right) A fractional factorial 4-run orthogonal design for 3 factors.





| Α | UT Field Work | Exa | mpl | е |
|------------|---|-------------|--------|------|
| | (Proprietary data cha to protect owner's | nged IP) | | |
| Facto | r Title (Unit) | Low | Center | High |
| X 1 | Operator's Experience (Year) | 2.0 | 4.0 | 6.0 |
| X2 | UT Machine Age (Year) | 2.0 | 5.0 | 8.0 |
| X3 | Cable Length (feet) | 6.0 | 8.0 | 10.0 |
| X4 | Transducer Probe Angle (deg.) | 42.0 | 45.0 | 48.0 |
| X5 | Plastic Shoe Thickness (in.) | 0.25 | 0.50 | 0.75 |







Tool-6

Non-Linear Least SQuares with Logistic Function

(*NLLSQ* - Lgs).

5/4/2018





Tool-6 Non-Linear Least SQuares with Logistic Function (*NLLSQ* - Lgs).

$f(\mathbf{X}) = y_1 - L^* \{ \exp(-k^* (\mathbf{X} - a)) / (1 + \exp(-k^* (\mathbf{X} - a))) \},\$

Pierre Francois Verhulst (1845)



fong81a.dp





Element Size: Fine







Element Size: Fine



















Summary of Six Tools of UQ

| | | New Concept ? | New Software ? |
|----------|--|---|---|
| 3.1 | GoF / 64 | No. | Dataplot |
| 3.2 | coni , Predi , <i>LTL</i> | No. | Dataplot, R |
| 3.3 | LLSQ - Regression | No. | Dataplot, R |
| 3.5 | R&R + ANOVA | No. | Dataplot, R |
| 3.5 | DEX | Yes. | Dataplot, R |
| 3.6 | NLLSQ | Yes. | Dataplot |
| 5/4/2018 | No. of Subtotal Slides Jeffrey T. Fo 20899 U Em | ong, NIST, Gaithersburg, MD SA. Tel: 1-301-975-8217 nail: fong@nist.gov | 50 Initional Institute of Standards and Technology |



4. UQ Tool-2, 3, 4, & 5 :

Brain Metrology

Research.

5/4/2018



PLOS ONE



PLOS ONE

Iacono, et al,

10(4): e 0124126

RESEARCH ARTICLE

MIDA: A Multimodal Imaging-Based Detailed Anatomical Model of the Human Head and

Neck U.S. FDA, Div. of Biomedical Physics, Silver Spile, MD

Maria Ida Iacono¹, Esra Neufeld², Esther Akinnagbe¹, Kelsey Bower¹, Johanna Wolf^{2,3}, Ioannis Vogiatzis Oikonomidis^{2,3}, Deepika Sharma^{2,3}, Bryn Lloyd², Bertram J. Wilm⁴, Michael Wyss⁴, Klaas P. Pruessmann⁴, Andras Jakab^{5,6}, Nikos Makris^{7,8}, Ethan D. Cohen¹, Niels Kuster^{2,3}, Wolfgang Kainz¹, Leonardo M. Angelone¹*

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4. Tool-2, 3, 4, 5 : Brain Metrology Research













4. Tool-2, 3, 4, 5 : Brain Metrology Research







4. Tool-2, 3, 4, 5 : Brain Metrology Research

| Table 3. Inter-operator variability across st | DICE | | | MHD (mm) | | | |
|---|----------|----------|----------|----------|----------|----------|--|
| Axial Segmentation | | | | | | ••• | |
| | 1 vs. GT | 2 vs. GT | 3 vs. GT | 1 vs. GT | 2 vs. GT | 3 vs. GT | |
| Adipose Tissue | 0.77 | 0.84 | 0.84 | 2.20 | 1.84 | 1.81 | |
| Brain Gray Matter | 0.82 | 0.96 | 0.95 | 0.84 | 0.43 | 0.48 | |
| Brain White Matter | 0.93 | 0.95 | 0.94 | 0.37 | 0.26 | 0.33 | |
| Brainstem Pons | 0.99 | 0.92 | 0.96 | 0.03 | 0.14 | 0.07 | |
| Cerebellum Gray Matter | 0.93 | 0.93 | 0.98 | 0.75 | 0.75 | 0.32 | |
| Cerebellum White Matter | 0.94 | 0.97 | 0.91 | 0.48 | 0.32 | 0.63 | |
| CSF General | 0.84 | 0.83 | 0.78 | 1.06 | 1.06 | 1.18 | |
| CSF Ventricles | 0.99 | 0.90 | 0.86 | 0.01 | 0.05 | 0.06 | |
| Dura | 0.77 | 0.68 | 0.77 | 1.07 | 1.24 | 1.07 | |
| Ear Auricular Cartilage (Pinna) | 0.74 | 0.80 | 0.84 | 0.15 | 0.13 | 0.12 | |
| Epidermis/Dermis | 0.76 | 0.82 | 0.80 | 1.65 | 1.43 | 1.52 | |
| Eye Aqueous | 0.81 | 0.79 | 0.82 | 0.13 | 0.13 | 0.13 | |
| Eye Lens | 0.94 | 0.92 | 0.77 | 0.03 | 0.02 | 0.06 | |
| Eye Vitreous | 0.90 | 0.94 | 0.99 | 0.16 | 0.15 | 0.01 | |
| Mandible | 0.96 | 0.97 | 0.93 | 0.08 | 0.06 | 0.11 | |
| Muscle (General) | 0.88 | 0.98 | 0.91 | 2.05 | 0.91 | 1.78 | |
| Parotid Gland | 0.96 | 0.96 | 0.96 | 0.17 | 0.18 | 0.18 | |
| Skull | 0,90 | 0.88 | 0.85 | 1.26 | 1.37 | 1.61 | |
| Spinal Cord | 0.98 | 0.96 | 0.99 | 0.01 | 0.02 | 0.01 | |
| Subcutaneous Adipose Tissue (SAT) | 0.82 | 0.94 | 0.96 | 2.07 | 0.94 | 0.72 | |
| Feeth | 0.93 | 0.84 | 0.83 | 0.22 | 0.38 | 0.38 | |
| Tongue | 0.99 | 0.94 | 0.93 | 0.07 | 0.19 | 0.22 | |
| /ertebrae | 0.95 | 0.91 | 0.96 | 0.07 | 0.11 | 0.06 | |





DICE

MHD (mm)

The Dice similarity index [61] and the modified Haussdorf distance [62] were used to quantify inter- and intra-operator variability. The Dice index D between segmentation 1 (S_I) and segmentation 2 (S_2), defined as:

$$D = 2\frac{S_1 \cap S_2}{|S_1| + |S_2|} \tag{1}$$

measures the extent of spatial overlap between S_1 and S_2 . The Dice index ranges between 0 and 1, with 1 signifying perfect agreement between the segmentations. The modified Hausdorff distance *MHD*, which measures the similarity between two shapes, is defined as:

$$MHD(S_1, S_2) = \max(d(S_1, S_2), d(S_2, S_1))$$
$$d(X, Y) = \frac{1}{N_X} \sum_{x \in X} \min_{y \in Y} ||x - y||$$
(2)

where $|| \cdot ||$ denotes the L2-norm and N_X denotes the number of elements in set X. Distance values close to 0 correspond to high matching between the boundaries.



4. Tool-2, 3, 4, 5 : Brain Metrology Research



suggested no significant inter-observer variability among operators in terms of D indexes (p-value = 0.61) and *MHD* values (p-value = 0.96) with 95% confidence.

4. Tool-2, 3, 4, 5: Brain Metrology Research





4. Tool-2, 3, 4, 5: Brain Metrology Research





4. Tool-2, 3, 4, 5 : Brain Metrology Research







4. Tool-2, 3, 4, 5 : Brain Metrology Research

2015 subset 15 Tissues each of which is a triple (3-dir) balanced

Direction (3)

| No. of | Subtotal |
|--------|-----------|
| Slides | |
| 11 | <i>59</i> |

| 2 8 1 | 2 8 1 | 2 3 1 | 2 3 1 | 2 3 1 | 128 | R | A 3 | 123 | 3 12 | 3 2 | 1 3 2 | 2 3 | 1 33 | 1 3 2 |
|---------------------|-----------------|---------------------|-----------------|---------------------|---------------------|----------|-----------------|-----------------|---------------------|---------------|---------------------|------------|------|------------------|
| P ³ | 23 1 | 23 | 1 23 | 8 1 | 2 1 ³ | 13 2 | 1 3 2 | 1 3 2 | 2 3 1 | 2 3 1 | 2 ³ 1 | 83 | 128 | 1 ₂ 3 |
| 2 1 ³ | 2 8 1 | 2 1 ³ | 128 | 1 ₃ 2 | 1 23 | 143 | 2 8 1 | 2 8 1 | 2 ⁸ 1 | 28 1 | 1.3 2 | 123 | 1.92 | 1 2 3 |

STAPLE/MIDA Inter-operator R&R Analysis





8.1 Uncertainty in all aspects of engineering from design to manufacturing, testing, operation, maintenance, and life extension, is quantifiable with the help of modern computing.

8.2 Uncertainty quantification (**UQ**), however, does not come without cost, and engineers need to learn how to perform an Elementary Probability Risk Analysis (EPRA) to justify the cost of **UQ** against the **benefit** of uncertainty-based asset management that reduces failure probability to an "acceptable" minimum.





Certain commercial equipment, instruments, materials, or computer software are identified in this talk in order to specify the experimental or computational procedure adequately. Such identification is not intended to imply recommendation or endorsement by the National Institute of Standards & Technology, nor is it intended to imply that the materials, equipment, or software identified are necessarily the best available for the purpose.





Speaker's Biographical Sketch



Dr. Jeffrey T. Fong has been Physicist and Project Manager at the Applied and Computational Mathematics Division, Information Technology Laboratory, National Institute of Standards and Technology (NIST), Gaithersburg, MD, since 1966.

He was educated at the University of Hong Kong (B.Sc., Engineering, first class honors, 1955), Columbia University (M.S., Engineering Mechanics, 1961), and Stanford (Ph.D., Applied Mechanics and Mathematics, 1966). Prior to 1966, he worked as a design engineer (1955-63) on numerous power plants (hydro, fossil-fuel, nuclear) at Ebasco Services, Inc., in New York City, and as teaching & research assistant (1963-66) on engineering mechanics at Stanford University.

During his 40+ years at NIST, he has conducted research, provided consulting services, and taught numerous short courses on mathematical and computational modeling with uncertainty estimation for fatigue, fracture, high-temperature creep, nondestructive evaluation, electromagnetic behavior, and failure analysis of a broad range of materials ranging from paper, ceramics, glass, to polymers, composites, metals, semiconductors, and biological tissues.

A licensed professional engineer (P.E.) in the State of New York since 1962 and a chartered civil engineer in the United Kingdom and British Commonwealth (A.M.I.C.E.) since 1968, he has authored or co-authored more than 100 technical papers, and edited or co-edited 17 national or international conference proceedings. He was elected Fellow of ASTM in 1982 and Fellow of ASME in 1984. In 1993, he was awarded the prestigious ASME *Pressure Vessels and Piping Medal.* Most recently, he was honored at the 2014 International Conference on Computational & Experimental Engineering & Sciences (ICCES) with a *Lifetime Achievement Medal.*

Since 2006, he has been Adjunct Professor of Mechanical Engineering and Mechanics at Drexel University and taught a graduate-level 3-credit course on "Finite Element Method Uncertainty Analysis." Since Jan. 2010, he has given every 6 months an on-line 3-hour short course at Stanford University on "Reliability and Uncertainty Estimation of FEM Models of Composite Structures." In 2012, he was appointed Adjunct Professor of Nuclear and Risk Engineering at the City University of Hong Kong, and Distinguished Guest Professor at the East China University of Science & Technology, Shanghai, China, to teach annually a 1credit 16-hour short course on "Engineering Reliability and Risk Analysis."



- 1. Why is UQ important in Engineering ?
- 2. Example of an *Easy-to-use* UQ Tool for Engineers.
- 3. Six Easy-to-use (ETU) Tools of Engineering UQ.
- 4. Tool-2, 3, 4, 5. UQ for Brain Metrology Research.
- 5. Tool-3, & 5. UQ for Flaw Detection and Sizing.
- 6. Tool-1 & 2. UQ for Design of an Aircraft Window.
- 7. Tool-6. UQ for Maintenance Decision Making.
- 8. Concluding Remarks.





5. UQ Tool-3, and 5 :

Flaw Detection and

Sizing (NDE UQ).





CLAD SURFACE

N P

A ____ D ___ G ___ J __

M -

⁴ Projection of Flaw (Typical)

NDE-UQ Approach No. 1

using **Tool-3 (LLNQ - Regression)**

| | PIRR | MRR | PISC-AST |
|-------------------------|-------|--------|----------|
| No. of Inspections | 553 | 309 | 133 |
| No. of Teams | 7 | 15 | 23 |
| No. of Assemblies | 86 | 20 | 6 |
| Ave. Wall Thickness, mm | 14 | 14 | 21 |
| Flaw depth, mm | | 9 N | |
| Min | 0.33 | 0.83 | 0.40 |
| Median | 2.41 | 4.78 | 4.50 |
| Max | 6.83 | 11.44 | 14.10 |
| Flaw Length, mm | | 0 - J | |
| Min | 3.05 | 3.30 | 0.52 |
| Median | 26.42 | 21.59 | 46.39 |
| Max | 59.19 | 130.80 | 108.20 |
| Total No. of Flaws | 45 | 15 | 26 |

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Table 2. Summary of First 3 NDE databases reported in [17].

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0 -

Flaw to be examined for sizing

using a design of experiments.





True depth (mm)





NDE-UQ Approach No. 2 using Tool-5 (DEX)

A UT Field Work Example

(Proprietary data changed to protect owner's IP)

| Factor | Title (Unit) | Low | Center | High |
|------------|-------------------------------|------|--------|------|
| X 1 | Operator's Experience (Year) | 2.0 | 4.0 | 6.0 |
| X2 | UT Machine Age (Year) | 2.0 | 5.0 | 8.0 |
| X3 | Cable Length (feet) | 6.0 | 8.0 | 10.0 |
| X4 | Transducer Probe Angle (deg.) | 42.0 | 45.0 | 48.0 |
| X5 | Plastic Shoe Thickness (in.) | 0.25 | 0.50 | 0.75 |







X3 = Cable Length (6, 8, 10); X4 = Probe Angle (42, 45, 48); X5 = Shoe Thickness (1/4'', 1/2'', 3/4''); Values (-, 0, +)

Ordered Response Y (Crack Length)

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2












Uncertainty Quantification of UT Measurement of Length of a Subsurface Crack 95 % Confidence Predictive Limits based on a Design of Experiments (DEX) Exercise



X3 = Cable Length (6, 8, 10); X4 = Probe Angle (42, 45, 48); X5 = Shoe Thickness (1/4", 1/2", 3/4"); Values (-, 0, +)



6. UQ Tool-1, and 2 :

Design of an

Aircraft Window

Ref.: Fuller, Jr., E. R., Freiman, S. W., Quinn, J. B., Quinn, G. D., and Carter, W. Craig, "Fracture mechanics approach to the design of glass aircraft windows: a case study," *Proc. Conf., SPIE - The International Society for Optical Engineering*, 26-28 July **1994**, San Diego, CA, Vol. 2286, pp. 419-430 (1994)

A simplified version of Equation (18) in the reference mentioned above appears on the next slide:





Expression for Time-to-Failure (t_f) :

$$\boldsymbol{t}_{f} = \frac{\lambda}{N'+1} \left(\frac{\boldsymbol{S}}{\boldsymbol{S}_{v}}\right)^{N'-2} \sigma^{-N'}$$

- S is the initial strength
- S_v is the strength of an indented reference set of specimens
- σ is the tensile stress in the component
- λ and N' are constants from environmentally enhanced crack growth

#Unit of $\mathbf{t}_{\mathbf{f}}$ is \mathbf{s} , unit of \mathbf{S} , $\mathbf{S}_{\mathbf{v}}$, σ is **MPa**, unit of $\boldsymbol{\lambda}$ is (**MPa**)^{N'} * \mathbf{s} , and **N'** is dimentionless.



Use Propagation of Errors to Combine Uncertainties in the 5 Parameters



Ref.: Fong, J. T., Marcal, P. V., Heckert, N. A., Filliben, J. J., and Freiman, S. W., "Confidence Interval Estimation for Location Parameter of a 3-Parameter Weibull Distribution," submitted to NIST Journal of Research, Dec. 2010. Contact <u>fong@nist.gov</u> for advance copy of an updated version of the manuscript.



| | | | | | 1.5 | 1000 | | -1 |
|----------------------------|--------|--------|--------|--------|--------|--------|--------|----|
| Failure Strongth Test Date | 129.83 | 143.42 | 149.33 | 158.79 | 160.17 | 165.83 | 167.69 | |
| ranure Strength Test Data | 175.82 | 175.96 | 177.89 | 184.03 | 184.58 | 184.65 | 186.51 | |
| Data Set No. 1 (Glass) | 190.79 | 206.16 | 214.50 | 228.91 | 232.57 | 232.78 | 233.67 | |
| Sampla Siza — 31 | 239.67 | 246.50 | 247.60 | 254.98 | 255.67 | 255.74 | 272.90 | |
| Sample Size – 51. | 303.69 | 312.28 | 312.90 | | | (Unit: | MPa.) | |





6. Tool-1, 2 : Design of an Aircraft Window.

| Candidate Model $\rightarrow \rightarrow \rightarrow$ | Normal | 2-para- Weibull | 3-para- Weibull | 2-para- Lognormal | 3-para- Lognormal |
|---|---|---|--|--|--|
| Lab-Scale Prediction (based on sample data) | KS-Goodness- of-Fit Metric = 0.151 | KS-Goodness- of-Fit Metric = 0.153 (worst) | KS-Goodness- of-Fit Metric = 0.117 (best) | KS-Goodness- of-Fit Metric = 0.122 | KS-Goodness- of-Fit Metric = 0.129 |
| Parameter-1 (Location = Mean of a normal distribution) | <i>Mean</i> = 212.4 | None | <i>S</i> _m = 121.7 | None | 41.8 |
| Standard deviation of Location | sd(<i>Mean</i>) = 9.0 | None | sd(<i>S</i> _m) = 12.1 | None | 77.3 |
| Parameter-2 (Scale = SampleSD of a normal distribution) | Sample. SD = 50.0 | <i>5</i> ₀ = 232.2 | <i>S</i> ₀ = 102.3 | 206.9 | 163.6 |
| Standard deviation of Scale | sd(Samp <i>SD</i>) = 6.5 | sd(<i>S</i> ₀) = 9.5 | sd(<i>S</i> ₀) = 11.8 | 8.9 | 81.1 |
| Parameter-3 (Shape) Standard deviation of Shape | None None | <i>m</i> ₂ = 4.64 sd(<i>m</i> ₂) = 0.65 | <i>m</i> ₃ =1.91 sd(<i>m</i> ₃) = 0.45 | 0.24 | 0.29 0.15 |
| Full-Size Component-Scale Prediction (based on lab scale sample-size data) | Tolerance Limit Uncertainty = 38 % (worst) | Toler. Limit Uncertainty = 30 % | Toler. Limit Uncertainty = 11 % (best) | Toler. Limit Uncertainty = 16 % | Toler. Limit Uncertainty = 19 % |
| 95% Confidence, 99% coverage (Lower Tolerance Limit, Mean, Upper Tolerance Limit) | (<mark>51.7,</mark> 96.1, 124.1) | (<mark>60.0,</mark> 86.1, 112.5) | (<mark>116.3,</mark> 130.9, 145.5) | (<mark>97.2,</mark> 119.8, 136.6) | (<mark>101.3,</mark> 124.8, 148.4) |

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6. Tool-1, **2** : Design of an Aircraft Window.

| Candidate Model $\rightarrow \rightarrow \rightarrow$ | Normal | 2-para- Weibull | 3-para- Weibull | 2-para- Lognormal | 3-para- Lognormal | |
|---|--|---|--|---|--|--|
| Lab-Scale Prediction (based on sample data) | ic-coodness- of-Fit Metric = 0.151 | KS-Goodness- of-Fit Metric = 0.153 (worst) | KS-Goodness- of-Fit Metric = 0.117 (best) | KS-Goodness- of-Fit Metric = 0.122 | KS-Goouness of-Fit Metric = 0.129 | |
| Parameter-1 (Location = Mean of a normal distribution) | <i>Mean</i> = 212.4 | None | <i>S</i> _m = 121.7 | None | 41.8 | |
| Standard deviation of Location | sd(<i>Mean</i>) = 9.0 | None | sd(<i>S</i> _m) = 12.1 | None | 77.3 | |
| Parameter-2 (Scale = SampleSD of a normal distribution) | Sample SD = 50.0 | <i>S</i> ₀ = 232.2 | <i>S</i> ₀ = 102.3 | 206.9 | 163.6 | |
| Standard deviation of Scale | sd(Samp <i>SD</i>) = 6.5 | sd(<i>S</i> ₀) = 9.5 | sd(<i>S</i> ₀) = 11.8 | 8.9 | 81.1 | |
| Parameter-3 (Shape) Standard deviation of Shape | None | $m_2 = 4.64$ sd(m_2) = | m₃ =1.91 sd(m₂) = | 0.24 | 0.29 | |
| | None | 0.65 | 0.45 | 0.03 | 0.15 | |
| Full-Size Component-Scale Prediction (based on lab scale sample-size data) | Tolerance Limit Uncertainty = 38 % (worst) | Toler. Limit Uncertainty = 30 % | Toler. Limit Uncertainty = 11 % (best) | Toler. Limit Uncertainty = 16 % | Toler. Limit Uncertainty = 19 % | |
| 95% Confidence, 99% coverage (Lower Tolerance Limit, Mean, Upper Tolerance Limit) | (<mark>51.7,</mark> 96.1, 124.1) | (<mark>60.0,</mark> 86.1, 112.5) | (<mark>116.3,</mark> 130.9, 145.5) | (<mark>97.2,</mark> 119.8, 136.6) | (<mark>101.3,</mark> 124.8, 148.4) | |

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6. Tool-1, 2 : Design of an Aircraft Window.



BK-7 Glass (20 C) Fracture Strength (MPa)

5/4/2018





7. UQ Tool-6 Application:

Maintenance

Decision Making.















7. Tool-6 Application: Maintenance Decision Making.



LOG_10 (X) where X = degrees of freedom (d.o.f.) ofABAQUS Solutions of Elbow-Crack Problem with 5 runs of Hex-08 (blue dots) and extra 6th run (red circle).

018 (Prof. M. Tuttle, ber

y Test (2002).

minutes)

of FEM.

ccuracy.

2nd Metric.

Conclusion.





ABAQUS Elbow Solution with Hexa-08 Elements from Coarse (21K dof) to Fine (122K dof) Meshes fem10b_elbow_11+bounds.dp









LOG_10 (X) where X = degrees of freedom (d.o.f.) of FEM Elbow Solutions with MPACT-Hexa-27, ABQ-Hexa-08 & -20 Elements from Coarse to Fine Meshes



| No of slides Subtotal | A 900-mi deg. El crack in | n (36-in bow wit one of i |) o.d. Pipe th a surface its two wel | 90- e ds | | A k sur 50 10 | prigitudinal face crack, mm long, mm deep, with az, opening |
|-----------------------|---|---|---|---|---|---|---|
| <i>8 24</i> | Est. Max. Cro 1 billion (1 using a Nonli of 5 or mor mesh design | ack Tip Stre 0 ⁹) degra near Least e FEM solu at increas | ess SXX (MP) ees of freed Squares Logist tions of the sa ing mesh dens | a) at dom tic Fit me sities | | Exed at th | to e end of a vertical aight pipe section. |
| | FEM Code- Element Type <i>No. of Runs</i> (Best Estimated Solution) | 95 % Lower Limit at 10 ⁹ d.o.f. (MPa) | Predicted Max. Crack Tip Stress at 10 ⁹ d.o.f. (MPa) | 95 % Upper Limit at 10 ⁹ d.o.f. (MPa) | Stand. Dev. (S.D.) at 10 ⁹ d.o.f. (MPa) | Coeff. of Variation (C.V.) at 10 ⁹ d.o.f. (%) | Ranking of Solutions by C.V. (least being the best) |
| ABAQUS | ABQ-Hex20 7 runs (455.20) | 407.32 | 457.96 | 508.60 | 19.70 | 4.30 % | 6 |
| ΠΕΧα-20 | ABQ-Hex20 <i>9 runs</i> (455.50) | 413.80 | 454.23 | 494.67 | 17.10 | 3.76 % | 5 |
| | ABQ-Hex20 10 runs (455.50) | 418.74 | 453.17 | 487.61 | 14.93 | 3.29 % | 4 |
| Hexahedron- 27 nodes | MPACT- Hex27 5 runs (345.48) | 345.10 | 345.47 | 345.85 | 0.12 | 0.03 % (lowest) | 1 |
| or, Hexa-27 | ABQ-Hex08 5 runs (220.00) | 203.02 | 246.05 | 289.09 | 13.52 | 5.49 % | 7 |
| ABAQUS | ABQ-Hex08 9 runs (228.30) | 215.78 | 233.37 | 250.96 | 7.44 | 3.19 % | 3 |
| Hexa-08 | ABQ-Hex08 11 runs (230.10) | 220.56 | 231.69 | 242.82 | 4.92 | 2.12 % | 2 |